### **Biometrics**

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#### Overview

- Modifications to NIST SP 800-76-2 (circa 2013)
  - Outdated references
  - New technologies
  - Updated compliance testing
- Aim for <u>no</u> breaking changes to:
  - Existing capture devices
  - Accuracy specifications
  - Template standards
  - Modalities



# Fingerprint Image Quality

- Migrate NFIQ to NFIQ 2.0
  - Higher-resolution quality
  - Better predictor of accuracy
  - Based on multiple features
  - Standardized as ISO/IEC 29794-4:2017
  - Worldwide adoption
- Re-evaluate thresholds for "good" quality
  - Previously NFIQ 1 or 2 "transformed" to 100 and 80.
- Revise NIST IR 7422 to use NFIQ 2.0
  - Monthly summary of operational quality calculation



NFIQ: 1 NFIQ 2.0: 84 Source: NIST Special Database 302

# Non-Contact Fingerprint

- Devices exist in many forms
  - Only one certified
- Explicitly "Not for use with CJIS systems"
  - Verification only
- Products aligned for high-volume use







Source: NIST Special Database 302

## Non-Contact Fingerprint

- Limited analysis available. NIST needs data:
  - NFIQ 2.0 training
  - Algorithm testing

- Have you deployed a non-contact device?
  - Can you provide data to NIST for research?
    - greg@nist.gov to set up a data transfer agreement



#### Mobile Phone

 Use case: biometric verification to PIV enrollment data derived onto mobile phone

- Issues
  - Device-provided algorithm
    - No studies confirming algorithm accuracy/performance
    - Manufacturers not participating in studies
  - Device-provided sensor
    - No studies/confirmation of device liveness detection
    - Fingerprint: is sensor FBI Appendix F or PIV certified?
  - Secure enclave storage of templates/images possible?



## Questions?



#### **Contact Information**

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